Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/720,472	JUN, JUNG SIG		
Examiner	Art Unit		
Krista M. Flanagan	2631		

SEARCHED					
Class	Subclass	Date	Examiner		
375	261 316 321 326 340 350	5/26/2005	KMF		
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348	725 726	5/26/2005	KMF		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SE	ARCH STRATE	GY)
	DATE	EXMR
EAST	5/26/200	05 KMF
Inventor Search	5/26/200	05 KMF
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